

Scanning transmission X-ray microscopy with efficient X-ray fluorescence detection (STXM-XRF) for biomedical applications in the soft and tender energy range

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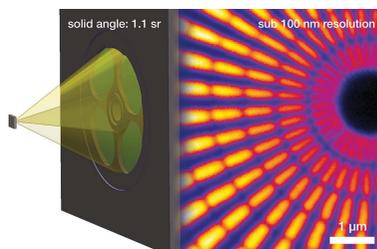
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Scanning transmission X-ray microscopy, especially in combination with X-ray fluorescence detection (STXM-XRF) in the soft X-ray energy range, is becoming an increasingly important tool for life sciences. Using X-ray fluorescence detection, the study of biochemical mechanisms becomes accessible. As biological matrices generally have a low fluorescence yield and thus a low fluorescence signal, high detector efficiency (*e.g.* large solid angle) is indispensable for avoiding long measurement times and radiation damage. Here, the new AnImaX STXM-XRF microscope equipped with a large solid angle of detection enabling fast scans and the first proof-of-principle measurements on biomedical samples are described. In addition, characterization measurements for future quantitative elemental imaging are presented.

1. Introduction

X-ray microscopy (XRM) can be performed either in full-field (FF-XRM) or scanning mode (STXM) (Eichert, 2015; Lider, 2017). In full-field mode the whole field of view is illuminated at once, whereas in scanning mode the sample is scanned by a focused beam and the signal for each point is recorded by an area detector. This makes STXM a more time-consuming method than FF-XRM, but has the advantage that a larger variety of contrast modes, such as absorption contrast, differential phase contrast and dark field contrast, can be performed simultaneously (Hornberger *et al.*, 2008). Furthermore, the small focus of the incoming beam on the sample allows the fluorescence radiation emitted by the excited atoms in the sample to be associated with a confined spatial position. The emitted fluorescence signal can be collected by a silicon-drift detector (SDD), so that the elemental composition of the sample can be determined. One of the unique features of the STXM-XRF setup presented here is the use of a four-channel SDD with flat design enabling a very large solid angle of detection (see Figs. 1 and 2).

FF-XRM, on the other hand, is not suitable for fluorescence microscopy, whereas phase retrieval is feasible but would require the implementation of additional optical elements such as Zernicke optics (Holt *et al.*, 2013). This is a complex task, since these optics (also known as phase rings) must be adapted to every sample, and the alignment as well as the



phase matching can be challenging. While FF-XRM can be performed at both synchrotron facilities and in the laboratory, scanning XRM depends on high-excitation intensities to avoid very long measuring times and is therefore available at synchrotron facilities only.

Synchrotron facilities at which FF-XRM in the soft and tender energy range has been established are: ALBA, ALS, Astrid, BESSY, Elettra, NSRL and Ritsumeikan. STXM measurements can be performed at ALS, BESSY, CLS, Diamond, Elettra, Photon Factory, SLS, SSRF and SSRL (Obst & Schmid, 2014). STXM in combination with fluorescence detection (STXM-XRF) can be found at CLS, Diamond and Elettra (TwinMic). CLS and Diamond use conventional SDDs with rather small angles of detection for the fluorescence signal. The TwinMic setup at Elettra includes a detector system of eight conventional SDDs arranged circularly around the sample. A new system with a larger solid angle of detection is also under development and is planned to be operational soon (Gianoncelli *et al.*, 2016; Bufon *et al.*, 2018).

The soft and tender energy range is particularly well suited for applications in life sciences, as it provides a higher sensitivity for the lighter elements. Due to the low fluorescence when investigating biological matrices, a high detector efficiency (achievable through a large solid angle) is indispensable for avoiding long measurement times and radiation damage.

Our novel AnImaX (analytical imaging with X-rays) endstation, that has been tested at the high-brilliance beamline P04 at PETRA III (DESY, Hamburg), features an integrated four-channel fluorescence detector with a large solid angle of detection of up to 1.1 sterad and can therefore combine STXM with fluorescence microscopy. The AnImaX microscope is designed as a flexible endstation adaptable to various beamlines. Alignment and first resolution tests with test patterns can be carried out within a day and a quick change between FF-XRM and STXM-XRF is possible [similar to TwinMic at Elettra (Kaulich *et al.*, 2003)]. However, the focus of this work will be on the characteristics and applications of the STXM-XRF mode.

In order to develop the fluorescence microscopy mode towards analytical imaging, *i.e.* towards the quantitative evaluation of fluorescence signals, the limit of detection (LOD) for some selected elements has been determined through the measurement of thin-layered samples (Hönicke *et al.*, 2018). These samples, with layer thicknesses in the nanometre regime, were specifically designed and produced for this purpose and possess a very homogeneous lateral distribution.

The first proof-of-principle experiments with respect to fluorescence microscopy were carried out to determine the iron distribution in brown adipose tissue (BAT). In response to cold exposure, BAT generates heat by a process called adaptive thermogenesis to maintain body temperature in cold environments (Heeren & Scheja, 2018). Accordingly, BAT has a high demand of energy-rich fuels and we used BAT activation to visualize the uptake of lipoproteins that were labelled with superparamagnetic iron oxide nanoparticles (Bruns *et al.*, 2009).

As radiation damage is often a serious issue for biological samples, we will provide an estimation of the radiation dose in different biomedically relevant matrices. In combination with our experimental results, these considerations demonstrate the necessity of a cryogenic environment for the samples.

2. Scanning transmission X-ray microscopy

Due to its flexible design, the presented scanning transmission X-ray microscope with X-ray fluorescence detection (STXM-XRF) is compatible with different beamlines. Since the resolution of a microscope in scanning mode depends on the size of the illumination spot, it is important to achieve a small X-ray focus on the sample. For this, our STXM-XRF is equipped with a zone plate (ZP) optic in combination with a central stop and an order-sorting aperture (OSA) (Fig. 1). For each scanning point, the transmitted signal is captured by a CCD area detector, so that additional contrast modes such as differential phase contrast can be exploited.

Furthermore, a four-channel SDD detector has been implemented into the setup so that simultaneous XRF measurements can be performed by recording the fluorescence emission spectrum for each scanning point. The detector consists of four independent SDDs aligned around a central hole through which the excitation beam is focused onto the sample. This geometry represents a unique feature of the AnImaX endstation, as it results in a very small distance between the detector and the sample, inducing a large angle of detection (Fig. 2).

2.1. AnImaX endstation

The AnImaX endstation is flexible in two ways. Firstly, it allows a quick change between full-field transmission

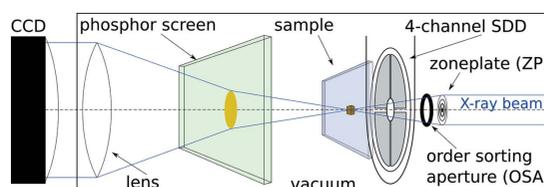


Figure 1
Sketch of the STXM setup.

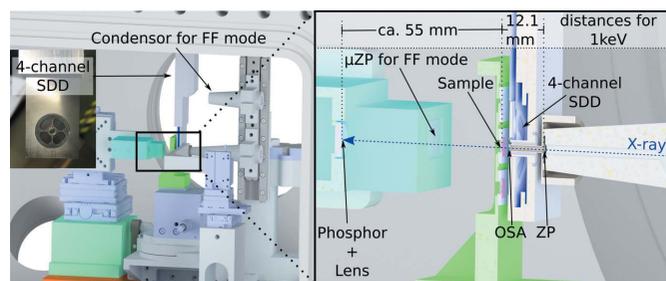


Figure 2
Drawing of the STXM setup with four-channel SDD entering from the top. For 1 keV, the distances of the phosphor, sample and ZP to each other are given.

(FF-XRM) and STXM-XRF mode. Secondly, it can easily be adapted, connected and transported to various beamlines without the need for special equipment. For experienced users, connecting the endstation to the beamline and aligning the STXM-XRF to the beam can be carried out within approximately 12 h.

In Fig. 1 an outline of the experimental setup depicts the arrangement of the optical elements. Fig. 2 shows a detailed drawing of the setup inside the vacuum chamber together with important distances for an excitation energy of 1 keV. The beam is focused by a Fresnel ZP with an outer diameter of 333 μm , an outer-zone width of 45 nm and a central stop of 160 μm in diameter. At a distance of approximately two-thirds of the focal length, a circular pinhole with a diameter of 150 μm serves as the OSA to suppress unwanted diffraction orders. The four-channel SDD is mounted from the top and is provided with a manual manipulator in three dimensions. This allows us to precisely align the four-channel SDD (XFlash 5060F from Bruker Nano GmbH) with the optical axis (manipulator in the x and y directions) and adjust its distance to the sample (manipulator in the z direction). The manipulator provides a large setting range, so that the four-channel SDD can be fully removed from the optical alignment by using the y manipulator (up–down).

The sample is mounted on a piezo scanner with a theoretical positioning accuracy of 0.1 nm and a total range of 100 μm \times 100 μm . The scanner itself is mounted on a coarse positioning stage that can be moved by piezos in the range of 63 mm in the x direction (horizontal to the optical axis) and 31 mm in the y direction (vertical to the optical axis) with an accuracy of 3 nm. Up to eight samples can be placed onto the sample holder, allowing the user to quickly switch between samples.

Placed behind the sample, a phosphor screen (P43) is excited by the transmitted X-rays and emits visible light. Due to the combination of the zone plate central stop and the OSA, the illumination has the shape of a hollow cone, resulting in a characteristic ring-shaped intensity distribution on the phosphor screen. The visible radiation emitted by the phosphor screen is collected by an optical achromatic lens (12.5 mm diameter, $f = 15$ mm) and detected by a fast-readout CCD camera (Andor IXon3 860, 128 \times 128 active pixels with 24 μm \times 24 μm) located outside the vacuum chamber equipped with an objective (Olympus, $f = 75$ mm–150 mm, F/4.0). Despite the low detection efficiency of this optical system, it is the acquisition time of the four-channel SDD that limits the total scanning time.

For STXM-XRF mapping, the sample is scanned in a plane perpendicular to the optical axis. This can be carried out either step-by-step, where the sample position is fixed for each measurement, or on-the-fly, for which the sample continuously moves during the measurements. On-the-fly scans can be controlled based on either time or position. For time-controlled measurements, the scanning positions and step widths are calculated based on acquisition time and velocity, whereas position-controlled measurements require encoder signals from the scanner, so that each measurement can be started when the sample has reached a certain position. The

results presented in this paper have been acquired in time-controlled mode.

One of the main challenges for successful STXM-XRF measurements is the proper synchronization of the scanner and the detectors for both the transmission and fluorescence measurements. Small mismatches of the scanner-to-detector synchronization might render time-consuming measurements unusable. Furthermore, it is necessary to synchronize the detectors with one another in order to compare the morphology of a sample (obtained by transmission measurements) with the elemental distribution in the sample (obtained by fluorescence detection).

The time-controlled scans in the presented STXM-XRF are based on transistor–transistor logic (TTL). At the start of each line, the scanner sends a signal to the transmission CCD. The CCD then collects a defined number of images with a defined acquisition time and waits for the next signal. For the acquisition time of the CCD, a constant TTL signal for the SDD is provided. Time delays are in the range of <10 μs due to the electric connections ($\sim\text{ns}$) and response times of the CCD (2–6 μs) and the SDD (~ 1 –2 μs).

As shown in Fig. 3, a time-controlled on-the-fly scan of a Siemens star test pattern (smallest structures: 50 nm) was performed without any artefacts, which indicates that the synchronization of scanner and CCD operates correctly. The Siemens star consists of a ~ 150 nm thick W layer on top of a 100 nm Si_3N_4 window. Fig. 3 shows an image recorded with an excitation energy of 720 eV in transmission mode only. The synchronization of the CCD detector with the four-channel SDD was tested for several other samples, *e.g.* for biomedical applications, which will be discussed below.

Since a Siemens star pattern displays a continuous range of structure sizes, *i.e.* spatial frequencies, it is a well suited test object to determine not only the spatial resolution limit of a microscope but also its contrast transfer function (CTF). In terms of the frequency spectrum of the object, the imaging system can be considered as a system that transfers the spatial frequency from the object to the image plane. The Siemens

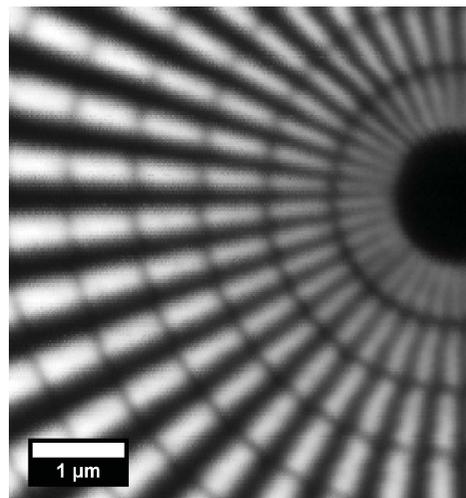


Figure 3
Transmission signal of a test pattern acquired in on-the-fly mode.

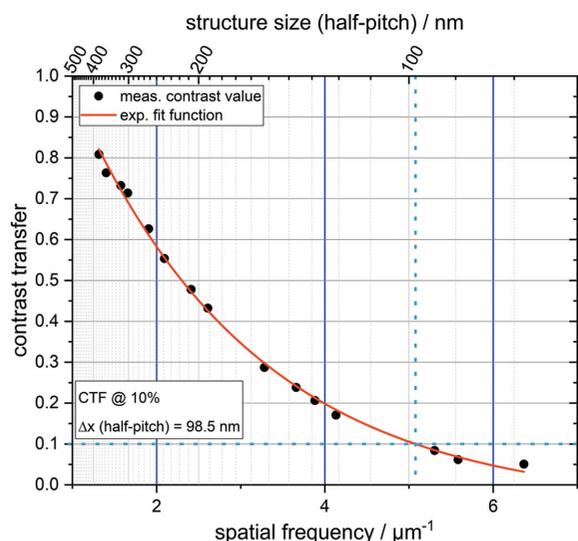


Figure 4
 Contrast transfer function (CTF) calculated with the Siemens star pattern from Fig. 3. The spatial frequency for which the CTF reaches 0.1 corresponds to the Rayleigh resolution limit and has been determined through the exponential fit function shown in the graph.

star image of Fig. 3 was used to calculate the contrast for different radial positions along the spherical pattern. Each radius corresponds to a certain spatial frequency and the contrast transfer decreases as the spatial frequency increases. In Fig. 4 the resulting CTF is presented. According to Smith (1997), a decrease in the contrast transfer to 10% corresponds to the Rayleigh resolution limit, *i.e.* the minimum distance between two object points for which they can still be distinguished in the corresponding image. In our case, the CTF reaches 10% at a spatial frequency of $5.1 \mu\text{m}^{-1}$, which corresponds to a half-pitch resolution of 98.5 nm. This result is in accordance with the visual perception of the pattern, where the smallest structures with sizes <100 nm are still discernible.

2.2. XRF: four-channel SDD

The four-channel SDD consists of four independent kidney-shaped SDD cells arranged like a cloverleaf around a central pinhole through which the excitation beam is guided to the sample (Fig. 2, right). Each SDD cell has an active area of about 15 mm^2 , resulting in an overall active area of 60 mm^2 .

Excitation radiation passes the central pinhole on the way to the sample and fluorescence radiation in backscatter geometry (Fig. 2, left) is detected on each of the four individual SDD cells. This geometry, in combination with the central pinhole and flat design, allows the detector to be positioned close to the sample and thus reach a very high solid angle of detection.

To shield the silicon chip from photoelectrons, it is equipped with a $0.5 \mu\text{m}$ -thick Mylar window. Due to this comparably thin window, the threshold energy of the four-channel SDD is reduced to 140 eV, assuming $\sim 15\%$ transmission through the Mylar window for a mean incidence angle of 45.5° at the optimum distance from the sample. Electrons up to ~ 3 keV are trapped in the Mylar window.

In contrast to the CCD, the readout time of the four-channel SDD is not the limiting factor. In theory, readout times can be set close to the response time ($\sim 1\text{--}2 \mu\text{s}$), but would be too short to gather meaningful XRF spectra. Estimations of reasonable minimal acquisition times can be carried out based on the maximum throughput of the four-channel SDD. Assuming fluorescence intensities close to the maximum throughput ($\sim 2 \times 10^6$ photons s^{-1} , according to the manufacturer) and at least 500–1000 events in the XRF spectrum, the minimum acquisition time would be 0.5 ms. This is in the same range as the acquisition time of the transmission detection system consisting of the CCD (2 ms without binning) and a phosphor screen (1 ms decay time). However, for real applications with sample inhomogeneities, acquisition times of at least 5 ms are necessary. For quantitative evaluation where elemental maps strongly depend on good counting statistics, even higher acquisition times are recommended.

In order to facilitate short measurement times, the four-channel SDD is operated in live-stream mode, where each event of the multi-channel analyser is transferred to the PC according to the sequence of the incoming photons. During the measurement, this live-stream is transformed into a spectrum for each measurement point, so that pre-selected regions of interest (ROIs) within these spectra can be summed. The ROIs, *i.e.* the elements of interest, are plotted once a scanned line is completed. Thus, a special map for each selected element is obtained, showing its occurrence and distribution within the sample.

A more precise spectrum evaluation requires a deconvolution of the characteristic lines, background stripping and consideration of detector effects (escape peaks, pile-up, sensitivity *etc.*) and has to be carried out after the experiments. Well known experimental conditions, combined with a careful fitting of the spectra and using the fundamental parameter (FP) method, will in principle enable quantitative imaging. However, absorption effects of the fluorescence radiation for large solid angles of detection in inhomogeneous samples need to be taken into account and present a challenge for real quantification.

2.2.1. Large solid angle of detection – optimum detector position. Due to its ring-like shape (see Fig. 2, right), the solid angle of detection as a function of distance d to the sample can be determined using the formula for circular detectors (Zaluzec, 2014). For a ring, the solid angle is simply the difference between the solid angle for full circles of the outer radius r_o and the inner radius r_i ,

$$\Omega(d) = 2\pi(1 - f_s) \times \left[\frac{r_o^2 + d^2 - d(r_o^2 + d^2)^{1/2}}{r_o^2 + d^2} - \frac{r_i^2 + d^2 - d(r_i^2 + d^2)^{1/2}}{r_i^2 + d^2} \right] \quad (1)$$

The factor $f_s \in [0; 1]$ describes the reduction of the active area by obstacles in the beam path, *e.g.* stabilization grids on the detector surface.

Table 1

Elemental composition of the XRF calibration sample.

Mass depositions are average values measured independently by GAAS, FAAS, ICP-OES and TXRF. Not all fluorescence lines listed here can be found in the XRF spectrum due to very low cross sections and absorption in the 0.5 μm Mylar window in front of the four-channel SDD. Fluorescence energies below the cut-off energy of ~140 eV of the system are not listed.

Element/ composition	Mass deposition (ng mm ⁻²)	Significant fluorescence lines with corresponding absorption edges excited by 1 keV (eV)†
Pb	84.9 ± 12.3	
La	121.4 ± 14.5	M5–N6,7 (836); M4–N6 (853); M4,5–N6,7 (647.2)
Pd	23.3 ± 4.5	M4,5–N2,3 (284.8)
Mo	8.6 ± 0.9	M4,5–N2,3 (193.5)
Cu	22.2 ± 3.3	L3–M5 (927.7); L2–M4 (947.3)
Fe	433.9 ± 5.9	L3–M5 (704.8); L2–M4 (717.9)
Si ₃ N ₄	Substrate	Si: L1–M2 (147.7) N: K–L2 (392.4); K–L1 (372.6)

† IUPAC notation; energies from the ELAM database (Elam *et al.*, 2002).

This function has a global maximum of $\Omega(d) = 1.1$ sterad at a distance of $d_{opt} = 2.42$ mm, where d_{opt} is the distance of the mounting of the four-channel SDD (not the active crystals) to the sample surface. Due to the very tight geometry of the setup, the distance to the active crystals of the four-channel SDD cannot be estimated during the alignment procedure. The value of d_{opt} varies slightly in an interval of $\pm\Delta d$ around the calculated value, so that in the range between $d_{min} = 1.81$ mm and $d_{min} = 3.28$ mm the solid angle of detection still exceeds 95% [$\Omega(d) = 1.05$ sterad]. It is therefore favourable to position the detector within this distance interval to the sample surface.

To verify the assumptions resulting from these calculations, a homogeneous sample (Table 1) was measured with an excitation energy of 1.5 keV and XRF spectra were collected for different sample-to-detector distances. The results are presented in Fig. 5, where the intensity in counts per second (in the energy range 0.253–1.341 keV) has been plotted as a function of the distance between the sample surface and the mounting of the four-channel SDD. The fitted curve (grey) was obtained by adapting the distance-offset mentioned above

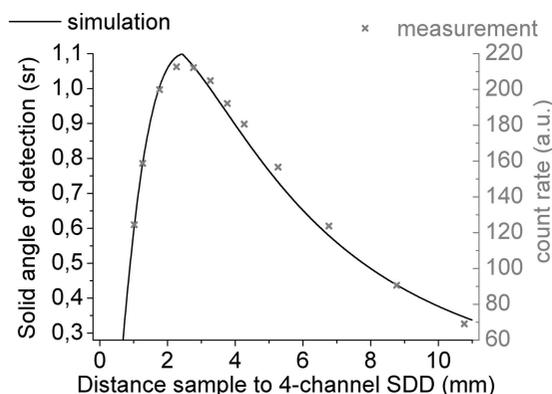


Figure 5

Distance dependence (four-channel SDD to sample) of measured and simulated intensities.

and the maximum solid angle of detection was correlated to the maximum detected intensity.

2.2.2. Large solid angle of detection – absorption effects. A large solid angle of detection is directly associated with a variation of the observation angle. In the common approaches for XRF quantification relying on the Sherman equation, the entrance and exit beams are considered to be well collimated. In particular, the detector is assumed to subtend only a small solid angle of detection (Sherman, 1955). Of course, this assumption is not valid for solid angles of detection of up to 1.1 sterad.

Although the problem of divergent angles and explicitly large solid angles of detection has been researched with various approaches ever since Sherman published his article in 1955 (Bonizzoni *et al.*, 2006; Chang & Wittry, 1994; Malzer & Kanngießer, 2003; Mantler & Kawahara, 2004; Pavlinsky & Kitov, 1979), no full analytical incorporation of divergent angles into the Sherman equation has yet been published or adopted by standard quantification algorithms. Nevertheless, for homogeneous samples, the equivalent angle approach, like the equivalent angle model by Malzer & Kanngießer (2003), is applicable for our STXM-XRF experiments.

In cases of inhomogeneous samples, where the fluorescence radiation is not only attenuated by different pathways through the sample but also by different matrices, approaches like the equivalent angle model by Malzer & Kanngießer (2003) become obsolete. Here, a reliable quantification approach has yet to be developed.

3. Experimental

Experiments were primarily carried out at the variable polarization XUV beamline P04 of PETRA III (Viefhaus *et al.*, 2013). P04 is currently one of the world’s most brilliant beamlines in the soft and tender X-ray range; the source brilliance is 10^{20} photons s^{-1} mm^{-2} $mrad^{-2}$ (0.1% bandwidth) $^{-1}$ (100 mA) $^{-1}$ and the resolving power exceeds 10 000 for the whole energy range 250–3000 eV. For our demands, a quasi-parallel beam with 5 mm (h) × 2 mm (v) beam size on the ZP was chosen.

The energy range which can currently be realized with the STXM-XRF setup ranges from 700 eV to 3000 eV. Since the four-channel SDD is placed between the sample and the zone plate, a further reduction of the sample–ZP distance, in order to access lower energies, is not possible. Therefore, energies lower than 700 eV are not accessible with the current ZP. A different type of focusing ZP can enlarge the energy range down to the limit of the beamline, which is currently marginally lower than the C K-edge at ~250 eV.

The flux on the sample was not measured directly due to the lack of a calibrated diode. Nevertheless, with the help of a well documented XRF calibration sample (Hönicke *et al.*, 2018), assuming a maximum solid angle of detection of 1.1 sterad, the photon flux on the sample is estimated to be $I_0 \approx 3 \times 10^9$ photons s^{-1} . Considering the ratio of the beam area to the active area of the ZP and the transmission of the ZP, this flux is in the expected range.

Table 2
Scan parameters at different spots on the XRF calibration sample.

Number of measurement points (h × v)	Step width (nm)	Acquisition time (ms)
100 × 100	1000	5
100 × 100	1000	10
100 × 100	1000	15
200 × 200	500	10
200 × 200	100	20

3.1. Limit of detection

A laterally homogeneous XRF calibration sample (Hönicke *et al.*, 2018) was used to estimate the limit of detection (LOD) for La, Cu and Fe. The XRF calibration sample consists of thin deposition layers of these elements on a commercially available silicon nitride membrane. The layer sequence, the average mass depositions and the fluorescence lines with their corresponding absorption edges for an excitation energy of 1 keV are listed in Table 1. To increase stability, XRF calibration samples are always covered with a thin C layer, but, since no mass deposition for C was determined, it is not listed in this table.

We recorded several lateral maps with varying acquisition times and step widths, as presented in Table 2. For 5 ms, 10 ms and 20 ms, single XRF spectra were used to estimate the LOD and were summed as ‘long-time spectra’. For example, 25 spectra from different positions with 20 ms acquisition times were summed in order to obtain the XRF spectrum for 500 ms. Our estimation of the LODs is based on the common definition (Streli *et al.*, 2006; Rousseau, 2001)

$$\text{LOD} = X_{\text{mcQ}} \left\{ \frac{3[(I_{\text{R}} - I_{\text{N}})/t]^{1/2}}{I_{\text{N}}} \right\} \quad (2)$$

where I_{R} represents the raw peak intensity, I_{N} is the net peak intensity and t is the acquisition time. The expression X_{mcQ} corresponds to the mass, the concentration or the mass deposition, depending on the method.

However, it is important to keep in mind that LODs only provide a rough estimation of detectable traces in samples. For strong overlapping fluorescence lines, this procedure cannot be applied.

The intensities I_{R} and I_{N} were determined by using the ROI procedure of *PyMCA* (Solé *et al.*, 2007). As shown in Table 1 and Fig. 6, the elements La, Cu and Fe generate intense *L*- or *M*-fluorescence lines for an excitation energy of 1 keV. Fig. 6 shows XRF spectra for 5 ms, 50 ms and 500 ms. The peaks are assigned to the respective elements. The additional elements, which are not mentioned in Table 1, are C (stabilization layer) and O. The latter originates from the Fe layer, since iron oxide was used as the target material for the Fe deposition layer.

The estimated LODs are presented in Table 3. The combination of the high-brilliance P04 beamline and the large solid angle of detection yields LODs in the range of 1 ng mm⁻² for an acquisition time of 20 ms for Cu, 50 ms for Fe and 500 ms for La. Due to the reduced photoproduction

Table 3
LOD for La, Cu and Fe for acquisition times varying from 5 ms to 800 s and an excitation energy of 1 keV.

Missing values are due to little statistics and a calculation of the background intensity of zero ($I_{\text{R}} - I_{\text{N}} = 0$).

Acquisition time (ms)	LOD _{La} (ng mm ⁻²)	LOD _{Cu} (ng mm ⁻²)	LOD _{Fe} (ng mm ⁻²)
5		10.42 ± 1.55	22.09 ± 2.96
20	25.59 ± 3.05	0.69 ± 0.10	2.00 ± 0.27
50	6.30 ± 0.75	0.41 ± 0.06	0.64 ± 0.09
500	0.83 ± 0.10	0.07 ± 0.01	0.12 ± 0.02
10000	0.05 ± 0.01	<0.01	0.01 ± <0.01
100000	<0.01	<0.01	<0.01

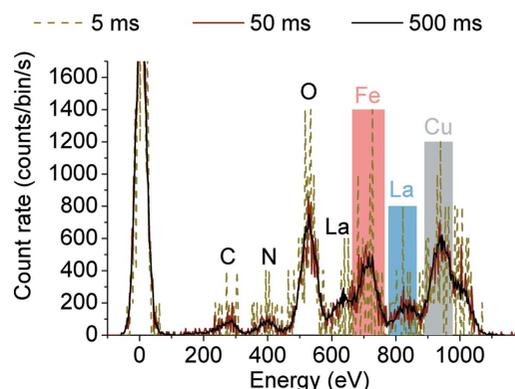


Figure 6
XRF spectra for 5 ms, 50 ms and 500 ms. ROIs used for the calculation of LOD are highlighted in red (Fe), blue (La) and grey (Cu).

cross section of the *M*-fluorescence, the acquisition time for La must be higher to obtain the same LOD. The excitation energy of 1 keV is very close to the Cu *L*_{III/II}-edge and thus Cu is the most sensitive element from this selection.

The high sensitivity for light elements of the AnImaX setup enables the analysis of trace elements in all kinds of application areas like biomedical, environmental or food production research. The access of imaging light trace elements in reasonable time periods opens complete new application fields. In addition, the sensitivity of *L*- and *M*-fluorescence allows the analysis of heavy trace elements at the same time. Previously, measurements had to be performed twice, at soft to tender and at hard beamlines, in order to access traces of light and heavy elements.

3.2. Biomedical application

Imaging is an important tool for biological and biomedical research and optical light microscopy is a well established method in laboratories all over the world. However, the spatial resolution of a microscope is limited by the wavelength of the probing radiation, which corresponds to a minimum of approximately 200 nm for visible-light microscopy (not taking into account novel super-resolution techniques). Therefore, methods with a higher spatial resolution are desirable. Even though electron microscopy can provide very high spatial resolutions in the Angstrom range, depth information can only

be gained at the price of extensive sample preparation. X-ray microscopy, owing to its relatively high penetration depth, is a promising approach here, especially when combined with fluorescence detection.

3.2.1. Biomedical application – proof of principle. The biochemical mechanisms governing the transport of lipids from blood vessels across the endothelial layer into parenchymal cells of the brown adipose tissue (BAT) of mammals are not yet understood in detail. Better insights into the involved mechanisms of transendothelial lipid transport are mandatory to develop novel therapeutic strategies for the treatment of hyperlipidemia and metabolic diseases such as diabetes mellitus type or non-alcoholic steatohepatitis (Scheja & Heeren, 2016).

In this study, we present the first proof-of-principle X-ray microscopy measurements on mice tissue samples. For this purpose, C57BL/6J mice receive an injection of lipoproteins labelled with superparamagnetic iron oxide (SPIO-lipoproteins) nanoparticles (Bruns *et al.*, 2009). To compare conditions of low and high organ-specific SPIO-lipoprotein uptake, mice were housed at ambient room temperature (low lipid uptake activity into thermogenic BAT) or at 6°C to activate thermogenesis. The cold activation stimulates an enhanced lipid uptake into BAT (Bartelt *et al.*, 2011; Schlein *et al.*, 2016; Heine *et al.*, 2018). Hence, a higher concentration of SPIO-lipoproteins, and thus higher Fe fluorescence in the BAT of cold-exposed mice in comparison with the control group, is expected.

The tissue samples of both groups were cut into slices of 4–8 μm thickness, fixated on a Si₃N₄ window (100 nm thickness) with 2.5% formaldehyde and air dried afterwards. For the investigation, an excitation energy of 1 keV was chosen, which is above and close to the Fe L_T-edge (0.8446 keV). The nominal SPIO particle size was specified to be ~10 nm, but agglomerations of the attached lipids were expected.

The tissue was scanned with a 100 nm step size and a 50 ms acquisition time in a range of 400 × 400 pixels. The resulting maps are shown in Figs. 7 and 8 at the bottom, where the detected C intensity is depicted in blue and the red represents the occurrence of Fe. At the top of Figs. 7 and 8, a transmission image of the exact same area is presented, so that structural and elemental information can be correlated. Since we know that brown adipocytes in BAT contains more C than blood vessels, we can conclude that the areas where high concentrations of C are detected correspond to adipocytes. Furthermore, as the natural concentration of Fe in organic tissue lies below the detection limit, the detected Fe fluorescence must correspond to the occurrence of SPIO-lipoproteins.

In Fig. 7, the recorded image presents some scanning artefacts as the same line was scanned several times due to a malfunction of the scanner controller. The repeated lines were cut from the image, resulting in a visible horizontal line. Furthermore, the storage ring changed from top-up to decay mode, causing a decrease in fluorescence and transmission intensity, visible in the bottom part of the image.

For the cold activated tissue in Fig. 8, the area in the black rectangle was scanned three times; each scan lasted for 50 ms.

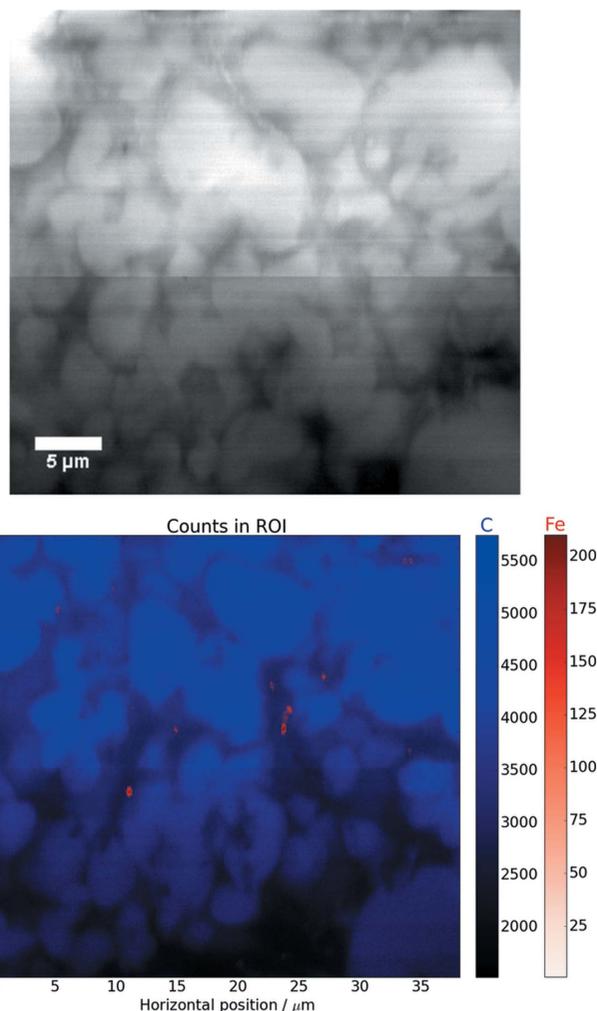


Figure 7 Transmission image (top) and pseudo-colour image (bottom) for C (blue, BAT) and Fe (red, SPIO) for control tissue.

In the transmission image this area appears much brighter than the rest, indicating radiation damage.

For a well grounded study of this biomedical research question, further measurements with higher statistics need to be performed.

Nevertheless, this example demonstrates the potential and possibilities of the AnImaX endstation with a large solid angle of detection in combination with the high-brilliance beamline P04 at PETRA III. To the best of our knowledge, a 50 ms acquisition time per pixel for the imaging of biomedical applications in the soft and tender X-ray range has not yet been achieved elsewhere.

3.3. Radiation damage – absorbed dose estimation

As shown in the previous section, radiation damage in biological samples can already be observed for very short measurement times of 50–150 ms per pixel. A first indicator for the estimation of radiation damage is the absorbed dose *D*. Depending on the application, signs of radiation damage were observed for *D* = 10⁴ Gy for unfixed hydrated biological samples (Schneider, 1998), for *D* = 10⁵ Gy for ascidian blood

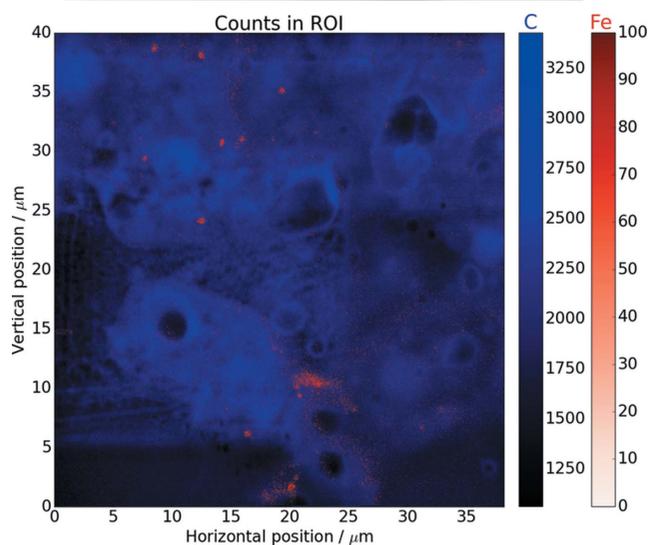
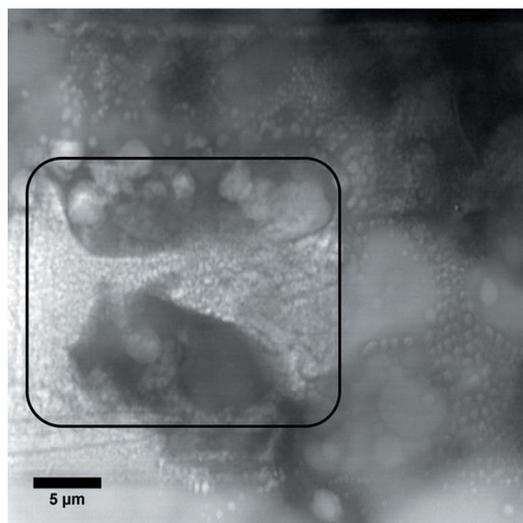


Figure 8
Transmission image (top) and pseudo-colour image (bottom) for C (blue, BAT) and Fe (red, SPIO) for cold-activated tissue. The box in the top image marks an area with radiation damage from previous scans (see text).

cells (Fayard *et al.*, 2009) and $D \simeq 10^7$ Gy for formalin-fixed cells (Gianoncelli *et al.*, 2015). The absorbed dose is defined as the ratio of the absorbed energy $\Delta E = I_A h\nu$ and the mass m ,

$$D = \Delta E/m \quad (3)$$

where I_A is the number of absorbed photons and $h\nu$ is the photon energy. I_A can be calculated based on the chemical composition, the density ρ and the thickness d of the sample. The mass can be estimated by assuming a rectangular illumination (volume $\simeq 100 \text{ nm} \times 100 \text{ nm} \times d$) and the sample density ρ .

Table 4 shows the empirical formulae and densities used for the dose estimation as well as the results of the calculated absorbed doses for 5 μm - and 10 μm -thick samples and 100 ms acquisition time. The results in Table 4 demonstrate that, for all examples, the absorbed dose lies in the range between 5.5×10^5 Gy and 9.5×10^5 Gy. As mentioned above, these are values for which radiation damage would already occur.

Table 4

Absorbed dose estimation for some applications in life science for 5 μm - and 10 μm -thick samples, an excitation energy of 1000 eV at P04 and a 100 ms acquisition time.

Application	Elemental formula	Density (g cm^{-3})	Dose for $d = 5 \mu\text{m}$, $t = 100 \text{ ms}$ ($\times 10^5$ Gy)	Dose for $d = 10 \mu\text{m}$, $t = 100 \text{ ms}$ ($\times 10^5$ Gy)
Adipose	$\text{C}_{57}\text{H}_{104}\text{O}_6$	0.94	6.6	8.9
Bone	$\text{O}_{1702}\text{H}_{429}\text{P}_{372}\text{Ca}_{620}\text{N}_{34}\text{C}_{134}$	1.70	5.5	5.6
Water	H_2O	1.00	8.4	9.4
Proteine	$\text{C}_{94}\text{H}_{139}\text{N}_{24}\text{O}_{31}\text{S}$	1.35	6.1	7.0

These considerations show the necessity of a cryogenic atmosphere for applications in life science. Under cryogenic conditions, radiation damage is strongly reduced and would only occur for absorbed doses in the range 10^8 – 10^9 Gy (Schneider, 1998). Hence, a cryogenic atmosphere would allow much better statistics and is therefore mandatory for quantitative analysis.

4. Conclusions

The AnImaX endstation is a flexible X-ray microscope, which can be operated in full-field as well as in scanning mode. Since we have enabled on-the-fly mapping with acquisition times of a few milliseconds per pixel for the scanning mode, very time-efficient mappings of dose-sensitive samples are achievable, which is of great advantage for the investigation of biological samples. Furthermore, an energy-dispersive detector (four-channel SDD) provides additional elemental information.

The implementation of the four-channel SDD detector, which was specially adapted for our setup, has been an important step in delivering correlated imaging and investigating the connection between structural and functional information in biological samples. With its large solid angle of detection of up to 1.1 sterad, acquisition times of less than 100 ms have become possible. With the help of well defined reference samples, it was possible to specify the LOD for La, Cu and Fe for different acquisition times. As a result, we could determine that an LOD of 1 ng mm^{-2} requires acquisition times of 500 ms for La, 20 ms for Cu and 50 ms for Fe. This example demonstrates that with this setup, in combination with a highly brilliant source, even trace elements with fluorescence lines of very low sensitivity, such as *M*-lines, can be detected.

The potential of AnImaX for biomedical applications in life science was demonstrated with the proof-of-principle measurements of SPIO-lipoprotein enriched BAT of cold-activated versus control mice. We were able to measure trace elements in these biomatrices with very short acquisition times of 50 ms, which is unprecedented in this energy range. Thus, AnImaX opens possibilities for various research fields such as the investigation of the toxicity of nanoparticles, the development of drug carriers or the processes of food production.

Nevertheless, even these short measurement times caused radiation damage. Hence, AnImaX will soon be equipped with a cryo-tomography station. A cryogenic environment reduces

radiation damage significantly and the rotation stage will allow us to perform FF-XRM tomography as a first step, followed by experiments to establish tomographic measurements in STXM mode. Longer measurement times facilitated by the cryogenic environment will also help to further develop our quantitative approach for large solid angles of detection.

In order to enlarge the research fields of the AnImaX setup even more, the energy range below 700 eV needs to be accessible. Different approaches like varying types of focusing ZPs or another mounting point of the OSA will be tested.

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